MOSFET – Power, Single, P-Channel, Trench, SC-88 -20 V, -4.2 A

NTJS4151P

Features

- Leading Trench Technology for Low R_{DS(ON)} Extending Battery Life
- SC-88 Small Outline (2x2 mm) for Maximum Circuit Board Utilization, Same as SC-70-6
- Gate Diodes for ESD Protection
- Pb-Free Package is Available

Applications

- High Side Load Switch
- Cell Phones, Computing, Digital Cameras, MP3s and PDAs

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	-20	V
Gate-to-Source Voltage	,		V_{GS}	±12	V
Continuous Drain	Steady State	T _A = 25 °C	I _D	-3.3	Α
Current (Note 1)	State	T _A = 85 °C		-2.4	
	t ≤ 5 s	T _A = 25 °C		-4.2	
Power Dissipation (Note 1)			P _D	1.0	W
Pulsed Drain Current $t_p = 10 \mu s$			I _{DM}	-10	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 150	°C
Source Current (Body Diode)			Is	-1.3	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C
ESD Human Body Model (HBM)			ESD	4000	V

THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State	$R_{\theta JA}$	125	°C/W
Junction-to-Ambient - t ≤ 5 s	$R_{\theta JA}$	75	
Junction-to-Lead - Steady State	$R_{ heta JL}$	45	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1

1. Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

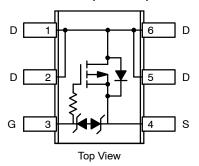


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} Typ	I _D Max
	47 mΩ @ –4.5 V	
-20 V	70 mΩ @ –2.5 V	-4.2 A
	180 mΩ @ –1.8 V	

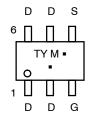
SC-88 (SOT-363)



MARKING DIAGRAM & PIN ASSIGNMENT



SC-88/SOT-363 CASE 419B



TY = Device Code

M = Date Code

Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information ion page 4 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J=25°C unless otherwise stated)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			•		•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	V _{GS} = 0 V, I _D = -250 μA		-12		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, T _J = 25°C			-1.0	μΑ
		$V_{DS} = 0 \text{ V},$ $V_{DS} = -16 \text{ V}$ $T_{J} = 85^{\circ}\text{C}$			-5.0	
Gate-to-Source Leakage Current	I _{GSS}				±1.5	μΑ
		V _{DS} = 0 V, V _{GS} = ±12 V			±10	mA
ON CHARACTERISTICS (Note 2)	•			ı		I
Gate Threshold Voltage	V _{GS(TH)}		-0.40		-1.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J	$V_{GS} = V_{DS}, I_D = -250 \mu A$		4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$R_{DS(on)}$ $V_{GS} = -4.5 \text{ V}, I_D = -3.3 \text{ A}$		47	60	mΩ
		$V_{GS} = -2.5 \text{ V}, I_D = -2.3 \text{ A}$		70	85	
		$V_{GS} = -1.8 \text{ V}, I_D = -1.0 \text{ A}$		180	205	
Forward Transconductance	9 _{FS}	$V_{GS} = -10 \text{ V}, I_D = -3.3 \text{ A}$		12		S
CHARGES AND CAPACITANCES				•		ı
Input Capacitance	C _{ISS}			850		pF
Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = -10 \text{ V}$		160		
Reverse Transfer Capacitance	C _{RSS}	VDS - 10 V		110		
Total Gate Charge	Q _{G(TOT)}			10		nC
Gate-to-Source Charge	Q _{GS}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_{D} = -3.3 \text{ A}$		1.5		
Gate-to-Drain Charge	Q_GD	. ID = -0.0 A		2.8		
SWITCHING CHARACTERISTICS (Not	e 3)			ı		I
Turn-On Delay Time	t _{d(ON)}			0.85		μs
Rise Time	t _r	Vce = -4.5 V. Vnn = -10 V.		1.7		
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_{D} = -1.0 \text{ A}, R_{G} = 6.0 \Omega$		2.7		
Fall Time	t _f			4.2		
DRAIN-SOURCE DIODE CHARACTER	RISTICS					
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V, } I_S = -1.3 \text{ A,}$ $T_J = 25^{\circ}\text{C}$		-0.75	-1.2	V
Reverse Recovery Time	t _{RR}			63		ns
Charge Time	Ta	$V_{GS} = 0 \text{ V, dI}_{S}/\text{dt} = 100$		9.0		
Discharge Time	T _b	- Α/μs, I _S = -1.3 Α		54		
Reverse Recovery Charge	Q _{RR}	1		0.23		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$. 3. Switching characteristics are independent of operating junction temperatures.

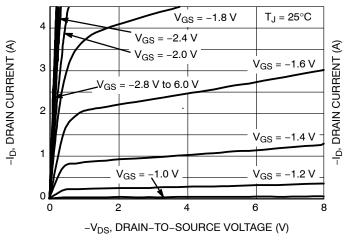
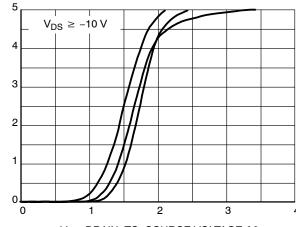


Figure 1. On-Region Characteristics



 $-V_{DS}$, DRAIN-TO-SOURCE VOLTAGE (V)



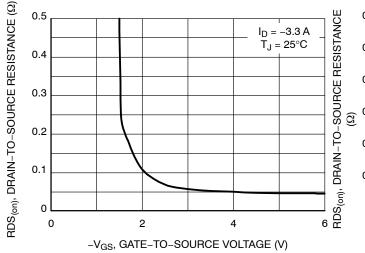


Figure 3. On-Resistance versus Gate-to-Source Voltage

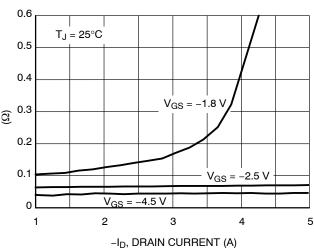


Figure 4. On-Resistance versus Drain Current and Gate Voltage

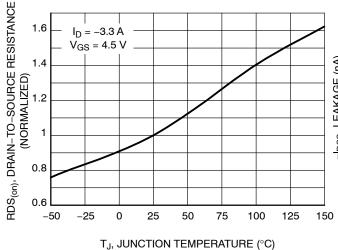
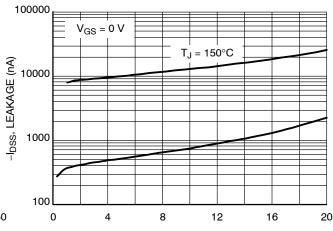


Figure 5. On–Resistance Variation with Temperature



-V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 6. Drain-to-Source Leakage Current versus Voltage

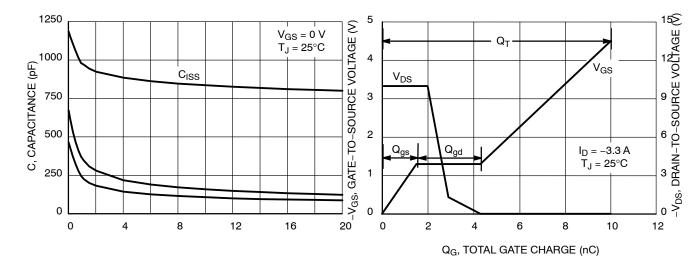


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

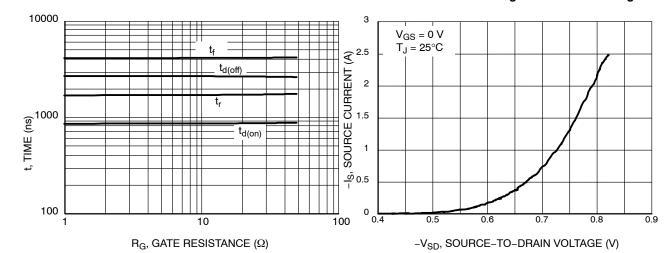


Figure 9. Resistive Switching Time Variation
Gate Resistance

Figure 10. Diode Forward Voltage versus Current

Table 1. ORDERING INFORMATION

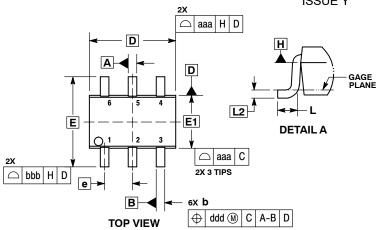
Part Number	Marking (XX)	Package	$Shipping^\dagger$
NTJS4151PT1	TY	SC-88	3000 / Tape & Reel
NTJS4151PT1G	TY	SC-88 (Pb-Free)	3000 / Tape & Reel

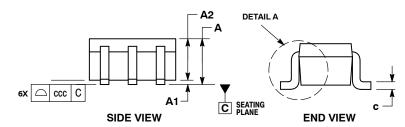
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

SC-88/SC70-6/SOT-363

CASE 419B-02 **ISSUE Y**





NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRU-SIONS, OR GATE BURRS SHALL NOT EXCEED 0.20 PER END. DIMENSIONS D AND E1 AT THE OUTERMOST EXTREMES OF

- DIMENSIONS D AND ET AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY AND DATUM H.

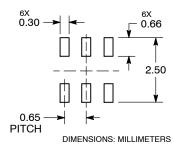
 DATUMS A AND B ARE DETERMINED AT DATUM H.

 DIMENSIONS 6 AND 6 APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN 0.08 AND 0.15 FROM THE TIP.

 DIMENSION 6 DOES NOT INCLUDE DAMBAR PROTRUSION.
- ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 TOTAL IN EXCESS OF DIMENSION b AT MAXIMUM MATERIAL CONDI-TION. THE DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OF THE FOOT.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α			1.10			0.043
A1	0.00		0.10	0.000		0.004
A2	0.70	0.90	1.00	0.027	0.035	0.039
b	0.15	0.20	0.25	0.006	0.008	0.010
С	0.08	0.15	0.22	0.003	0.006	0.009
D	1.80	2.00	2.20	0.070	0.078	0.086
E	2.00	2.10	2.20	0.078	0.082	0.086
E1	1.15	1.25	1.35	0.045	0.049	0.053
е	0.65 BSC			0.026 BSC		
L	0.26	0.36	0.46	0.010	0.014	0.018
L2	0.15 BSC			0.006 BSC		
aaa	0.15			0.006		
bbb	0.30			0.012		
ccc	0.10			0.004		
ddd	0.10				0.004	

RECOMMENDED **SOLDERING FOOTPRINT***



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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